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Substitute for form 1449A/B/PTO		<b>Complete if Known</b>			
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)		Application Number	09/763,515-Conf. #8620		
		Filing Date	February 23, 2001		
		First Named Inventor	Tetsuro Wada		
		Art Unit	1774		
		Examiner Name	J. M. Gray		
Sheet	1	of	1	Attorney Docket Number	21900-00021-US

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
<i>[initials]</i>	AA*	US-5,181,021	01-19-1993	Lee et al.	
<i>[initials]</i>	AB*	US-5,717,382	02-10-1998	Cooper	
<i>[initials]</i>	AC	US-5,896,087	04-20-1999	Frowein	

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>3</sup>
		Country Code <sup>4</sup> -Number <sup>5</sup> -Kind Code <sup>6</sup> (if known)				
[Handwritten Initials]	BA	EP-0 893 562-A1	01-27-1999	Le Van Hao et al		
	BB	DE-29 31 932-A1	02-26-1981	Teiter		
	BC	0 822 527-A1 EP	02-04-1998	Frowein		

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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>3</sup>

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Examiner Signature	<i>[Signature]</i>	Date Considered	1/06
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